Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/083,718	ALSLIETY, MAZEN K.	
Examiner	Art Unit	
Shih-Chao Chen	2821	

CEAD	CHED				
SEARCHED					
Subclass	Date	Examiner			
700MS, 792.5, 793, 795, 815	10/17/2005	CHEN			
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	700MS, 792.5, 793, 795, 815	700MS, 792.5, 793, 795, 815			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
343	700MS	10/17/2005	CHEN		
343	815	10/17/2005	CHEN		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (Search items: Yagi dipole, substrate, driven element, parasitic)	10/17/2005	CHEN		
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